


<b>Search Notes</b>  	<b>Application/Control No.</b>  10540729	<b>Applicant(s)/Patent Under Reexamination</b>  TAUNIER ET AL.
	<b>Examiner</b>  Arun S Phasge	<b>Art Unit</b>  1795

SEARCHED			
Class	Subclass	Date	Examiner
205	239-242	12/21/08	asp
205	251, 549, 557	1/28/10	asp

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor name searched in EDAN	12/10/08	asp
WEst his attached	12/21/08	asp
WEST his attached	1/28/10	asp

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
WEST his	attached	1/28/10	asp

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